

**Search Notes**

Application/Control No.

10/689,256

Examiner

Tan V. Mai

Applicant(s)/Patent under  
Reexamination

BEAUMONT, MARK

Art Unit

2193

**SEARCHED**

Class	Subclass	Date	Examiner
updated	search	6/17/2008	MAI

**INTERFERENCE SEARCHED**

Class	Subclass	Date	Examiner
708	207	6/17/2008	MAI
PGPUB text search (see interference search printout)		6/17/2008	MAI

**SEARCH NOTES  
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
Updated search (see printout)	6/17/2008	MAI